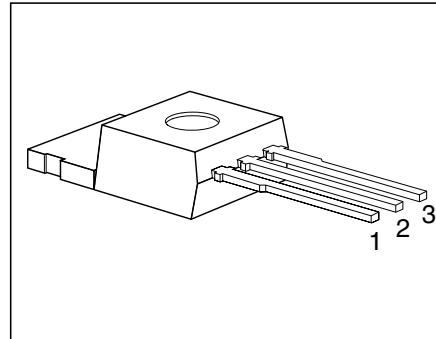


## Features

- N channel
- Enhancement mode
- Temperature sensor with thyristor characteristic
- The drain pin is electrically shorted to the tab



Pin	1	2	3
	G	D	S

Type	V <sub>DS</sub>	I <sub>D</sub>	R <sub>DS(on)</sub>	Package	Ordering Code
BTS 130	50 V	27 A	0.05 Ω	TO-220AB	C67078-A5001-A3

## Maximum Ratings

Parameter	Symbol	Values	Unit
Drain-source voltage	V <sub>DS</sub>	50	V
Drain-gate voltage, R <sub>GS</sub> = 20 kΩ	V <sub>DGR</sub>	50	
Gate-source peak voltage, aperiodic	V <sub>gs</sub>	± 20	
Continuous drain current, T <sub>C</sub> = 25 °C	I <sub>D</sub>	27	
ISO drain current T <sub>C</sub> = 85 °C, V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 0.5 V	I <sub>D-ISO</sub>	7.5	A
Pulsed drain current, T <sub>C</sub> = 25 °C	I <sub>D puls</sub>	108	
Short circuit current, T <sub>j</sub> = -55 ... + 150 °C	I <sub>SC</sub>	80	
Short circuit dissipation, T <sub>j</sub> = -55 ... + 150 °C	P <sub>SCmax</sub>	1200	
Power dissipation	P <sub>tot</sub>	75	W
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 ... + 150	
DIN humidity category, DIN 40 040	-	E	
IEC climatic category, DIN IEC 68-1	-	55/150/56	
Thermal resistance Chip-case	R <sub>th JC</sub>	≤ 1.67	K/W
Chip-ambient	R <sub>th JA</sub>	≤ 75	

### Electrical Characteristics

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

### Static Characteristics

Drain-source breakdown voltage $V_{GS} = 0, I_D = 0.25 \text{ mA}$	$V_{(BR)DSS}$	50	—	—	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	$V_{GS(\text{th})}$	2.5	3.0	3.5	
Zero gate voltage drain current $V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}$	$I_{DSS}$				$\mu\text{A}$
		$T_j = 25^\circ\text{C}$	1	10	
		$T_j = 125^\circ\text{C}$	100	300	
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0$	$I_{GSS}$				
		$T_j = 25^\circ\text{C}$	10	100	nA
		$T_j = 150^\circ\text{C}$	2	4	$\mu\text{A}$
Drain-source on-state resistance $V_{GS} = 10 \text{ V}, I_D = 17 \text{ A}$	$R_{DS(\text{on})}$	—	0.04	0.05	$\Omega$

### Dynamic Characteristics

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}, I_D = 17 \text{ A}$	$g_{fs}$	8.0	13.0	18.0	S
Input capacitance $V_{GS} = 0, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{iss}$	700	940	1250	pF
Output capacitance $V_{GS} = 0, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{oss}$	—	500	750	
Reverse transfer capacitance $V_{GS} = 0, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{rss}$	—	180	270	
Turn-on time $t_{on}$ , ( $t_{on} = t_{d(on)} + t_r$ ) $V_{CC} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_{GS} = 50 \Omega$	$t_{d(on)}$	—	25	40	ns
	$t_r$	—	60	90	
Turn-off time $t_{off}$ , ( $t_{off} = t_{d(off)} + t_f$ ) $V_{CC} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}, R_{GS} = 50 \Omega$	$t_{d(off)}$	—	100	130	
	$t_f$	—	75	95	

**Electrical Characteristics (cont'd)**

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

<b>Parameter</b>	<b>Symbol</b>	<b>Values</b>			<b>Unit</b>
		<b>min.</b>	<b>typ.</b>	<b>max.</b>	

**Reverse Diode**

Continuous source current	$I_S$	—	—	27	A
Pulsed source current	$I_{SM}$	—	—	108	
Diode forward on-voltage $I_F = 54 \text{ A}, V_{GS} = 0$	$V_{SD}$	—	1.5	2.0	V
Reverse recovery time $I_F = I_S, di_F/dt = 100 \text{ A}/\mu\text{s}, V_R = 30 \text{ V}$	$t_{rr}$	—	150	—	ns
Reverse recovery charge $I_F = I_S, di_F/dt = 100 \text{ A}/\mu\text{s}, V_R = 30 \text{ V}$	$Q_{rr}$	—	1.0	—	$\mu\text{C}$

**Temperature Sensor**

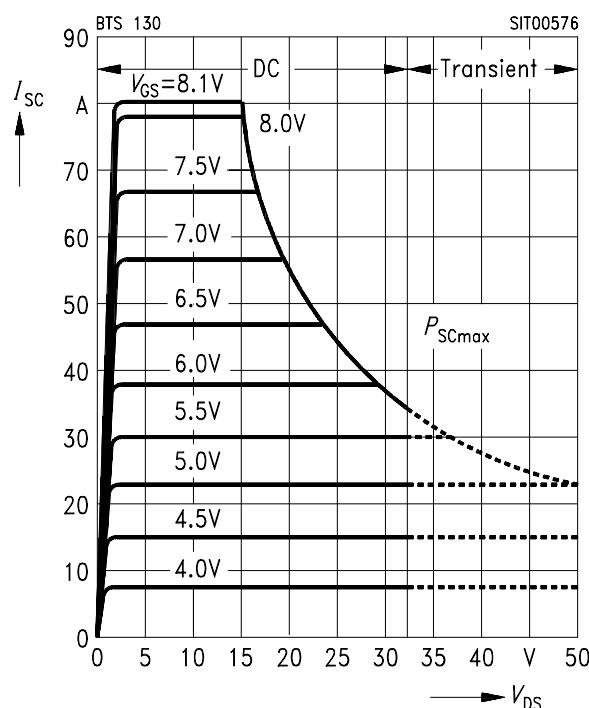
Forward voltage $I_{TS(on)} = 10 \text{ mA}, T_j = -55 \dots + 150^\circ\text{C}$ Sensor override, $t_p \leq 100 \mu\text{s}$ $T_j = -55 \dots + 160^\circ\text{C}$	$V_{TS(on)}$	—	1.4	1.5	V
—	—	—	—	10	
Forward current $T_j = -55 \dots + 150^\circ\text{C}$ Sensor override, $t_p \leq 100 \mu\text{s}$ $T_j = -55 \dots + 160^\circ\text{C}$	$I_{TS(on)}$	—	—	10	mA
—	—	—	—	600	
Holding current, $V_{TS(off)} = 5 \text{ V}$ , $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	$I_H$	0.05 0.05	0.1 0.2	0.5 0.3	
Switching temperature $V_{TS} = 5 \text{ V}$	$T_{TS(on)}$	150	—	—	$^\circ\text{C}$
Turn-off time $V_{TS} = 5 \text{ V}, I_{TS(on)} = 2 \text{ mA}$	$t_{off}$	0.5	—	2.5	$\mu\text{s}$

**Examples for short-circuit protection**

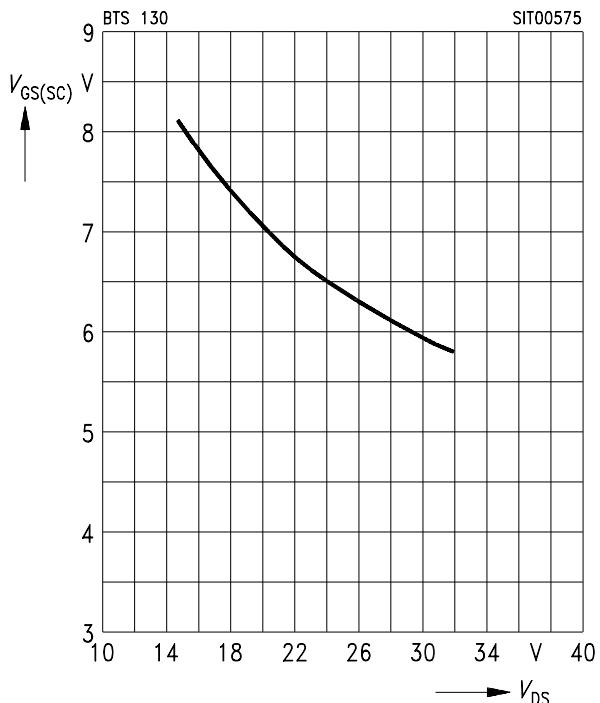
at  $T_j = -55 \dots +150^\circ\text{C}$ , unless otherwise specified.

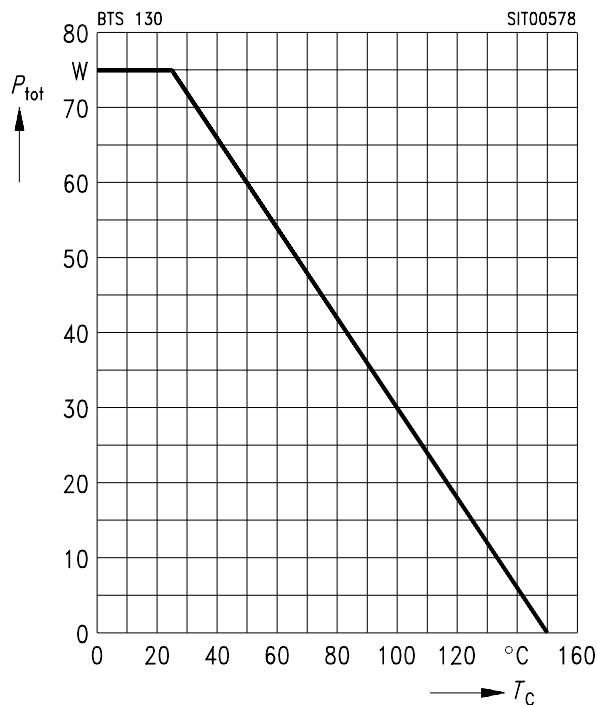
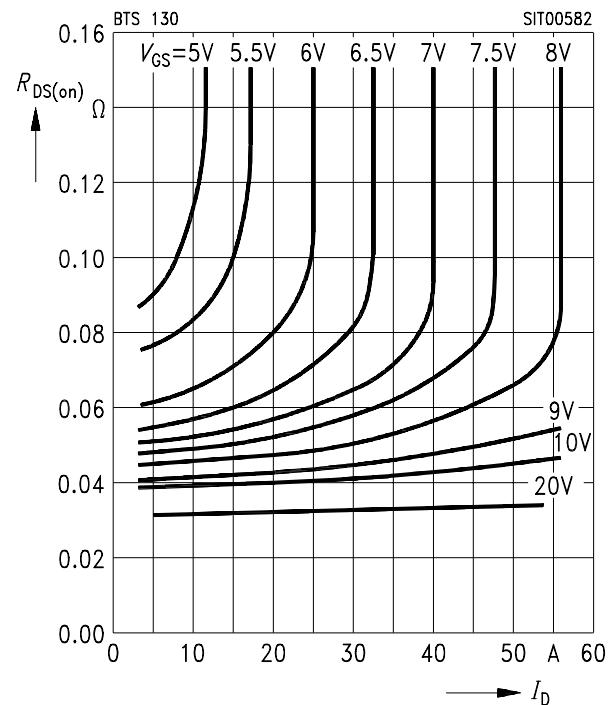
Parameter	Symbol	Examples			Unit
		1	2	-	
Drain-source voltage	$V_{DS}$	15	30	-	V
Gate-source voltage	$V_{GS}$	8.1	5.9	-	
Short-circuit current	$I_{SC}$	$\leq 80$	$\leq 37$	-	A
Short-circuit dissipation	$P_{SC}$	1200	1100	-	W
Response time $T_j = 25^\circ\text{C}$ , before short circuit	$t_{SC(\text{off})}$	25	25	-	ms

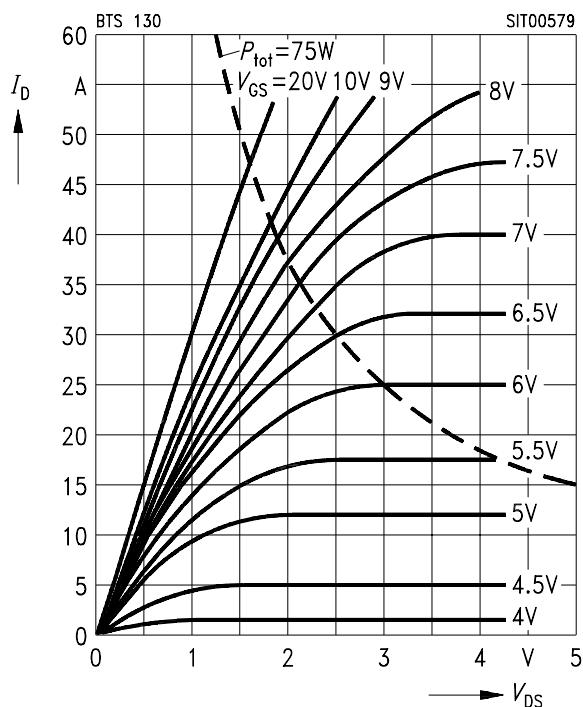
**Short-circuit protection**  $I_{SC} = f(V_{DS})$   
Parameter:  $V_{GS}$   
Diagram to determine  $I_{SC}$  for  $T_j = -55 \dots +150^\circ\text{C}$

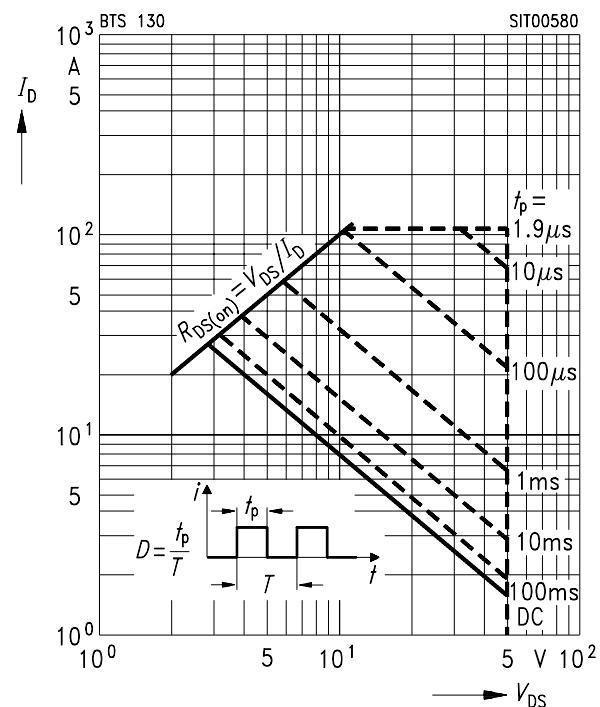


**Max. gate voltage**  $V_{GS(SC)} = f(V_{DS})$   
Parameter:  $T_j = -55 \dots +150^\circ\text{C}$



**Max. power dissipation  $P_{\text{tot}} = f(T_C)$** 

**Typ. drain-source on-state resistance**
 $R_{DS(\text{on})} = f(I_D)$   
 Parameter:  $V_{GS}$ 

**Typical output characteristics  $I_D = f(V_{DS})$** 

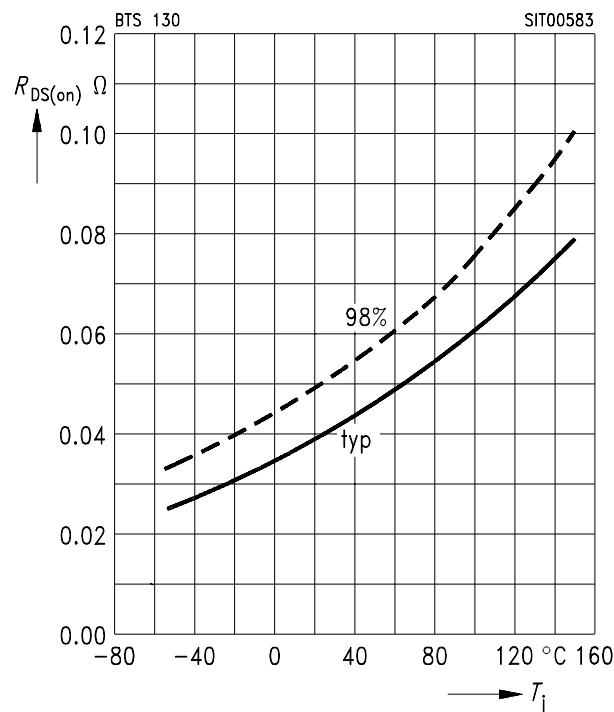
 Parameter:  $t_p = 80 \mu\text{s}$ 

**Safe operating area  $I_D = f(V_{DS})$** 

 Parameter:  $D = 0.01$ ,  $T_C = 25^\circ\text{C}$ 


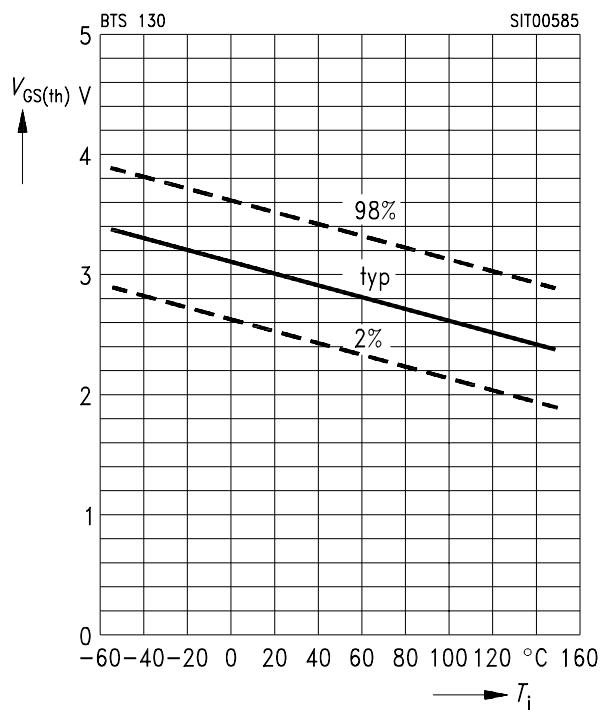
**Drain-source on-state resistance**

$$R_{DS(on)} = f(T_j)$$

Parameter:  $I_D = 17 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$  (spread)

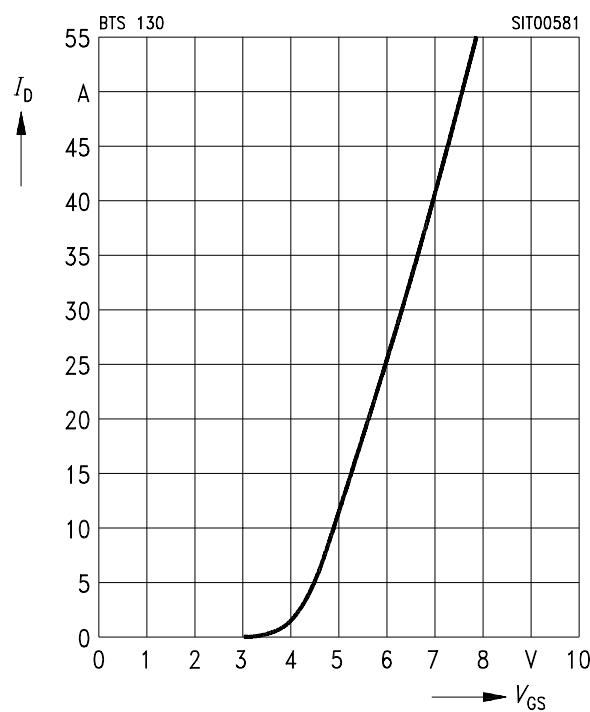

**Gate threshold voltage  $V_{GS(th)} = f(T_j)$** 

Parameter:  $V_{DS} = V_{GS}$ ,  $I_D = 1 \text{ mA}$

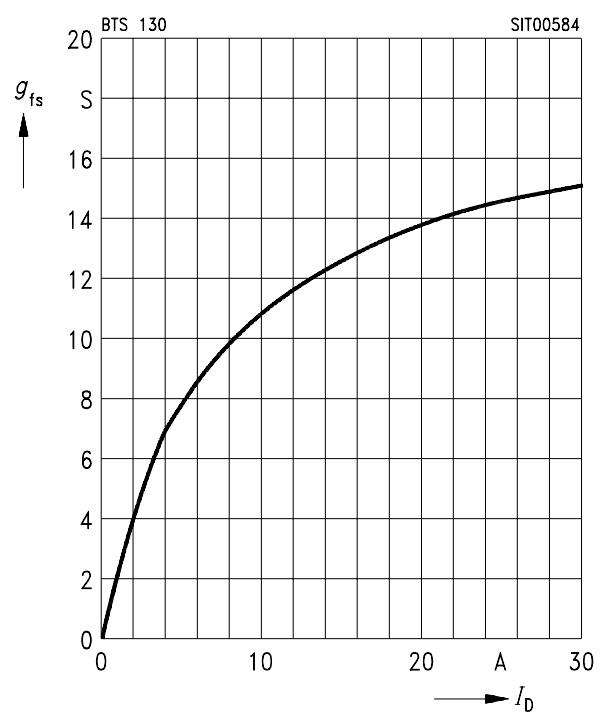

**Typ. transfer characteristic**

$$I_D = f(V_{GS})$$

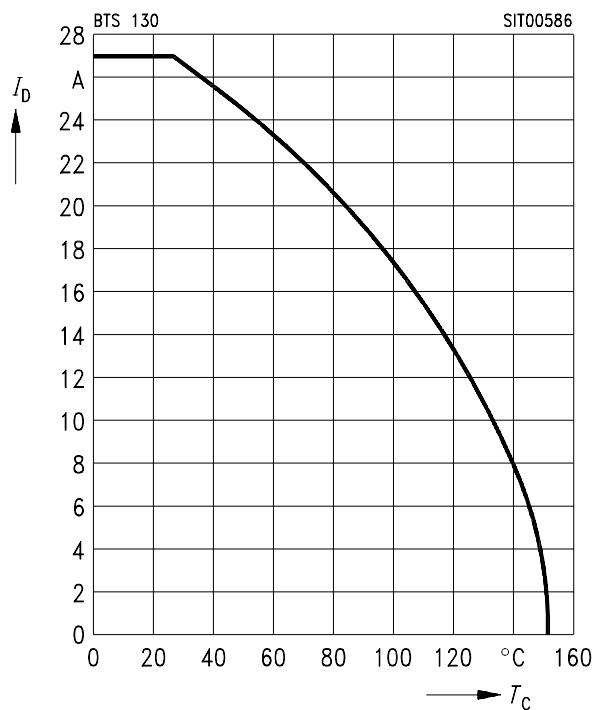
Parameter:  $t_p = 80 \mu\text{s}$ ,  $V_{DS} = 25 \text{ V}$


**Typ. transconductance  $g_{fs} = f(I_D)$** 

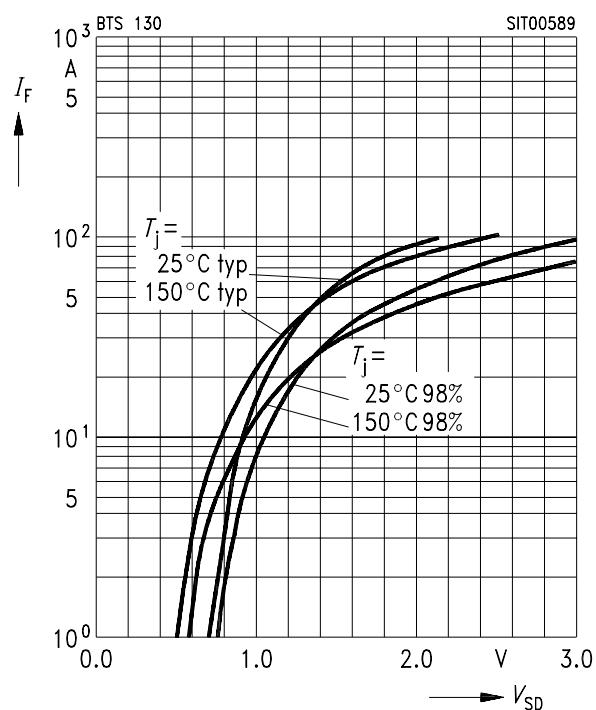
Parameter:  $t_p = 80 \mu\text{s}$ ,  $V_{DS} = 25 \text{ V}$



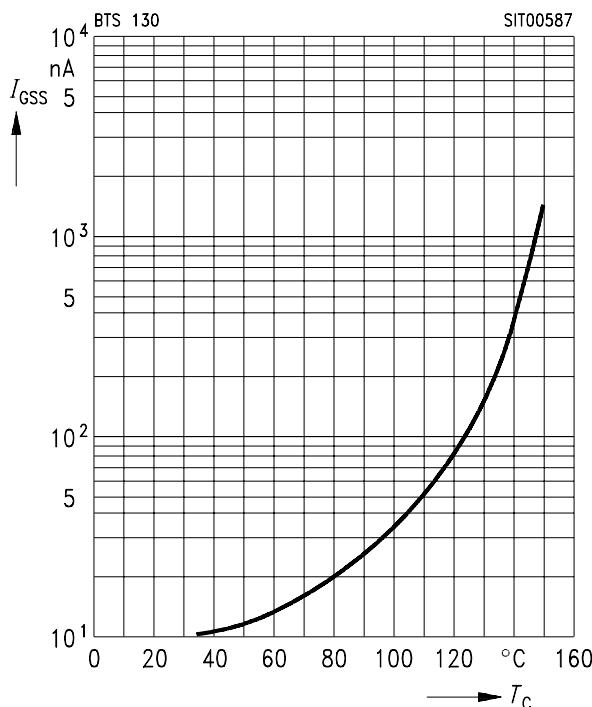
**Continuous drain current  $I_D = f(T_C)$** 

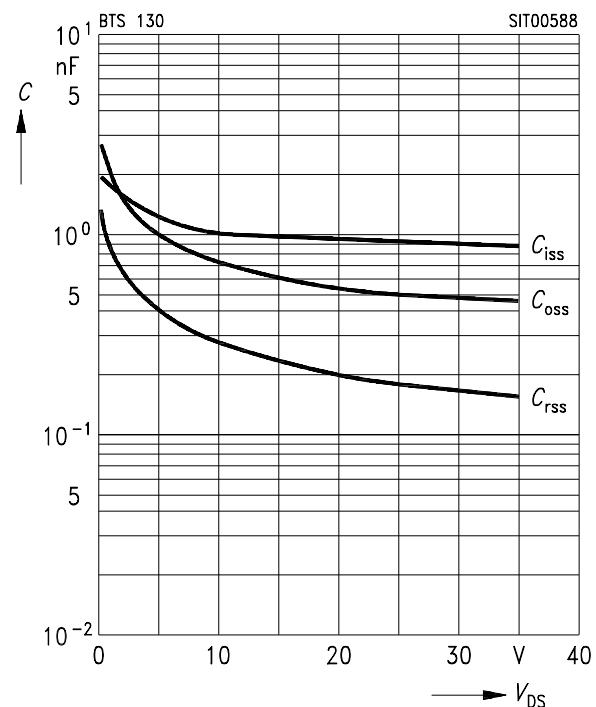
 Parameter:  $V_{GS} \geq 10$  V

**Forward characteristics of reverse diode**

$I_F = f(V_{SD})$

 Parameter:  $T_j, t_p = 80 \mu\text{s}$  (spread)

**Typ. gate-source leakage current**

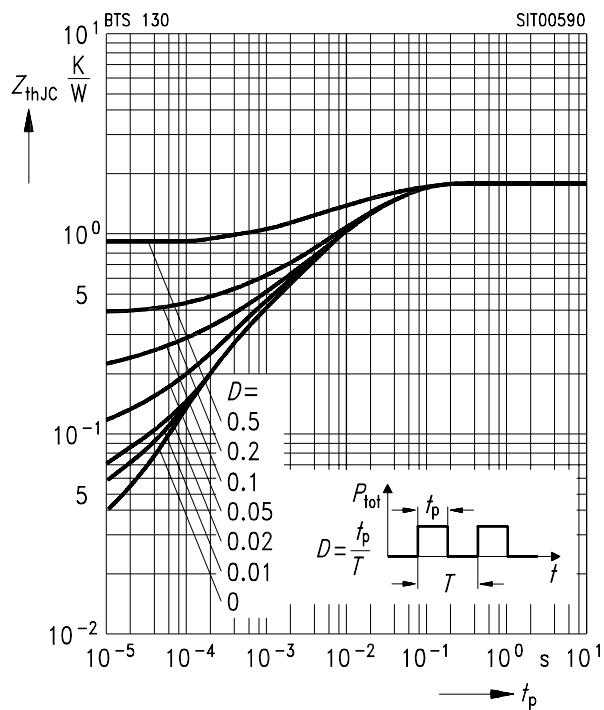
$I_{GSS} = f(T_C)$

 Parameter:  $V_{GS} = 20$  V,  $V_{DS} = 0$ 

**Typ. capacitances  $C = f(V_{DS})$** 

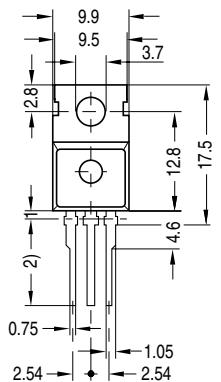
 Parameter:  $V_{GS} = 0, f = 1$  MHz


**Transient thermal impedance**  $Z_{\text{thJC}} = f(t_p)$

Parameter:  $D = t_p/T$

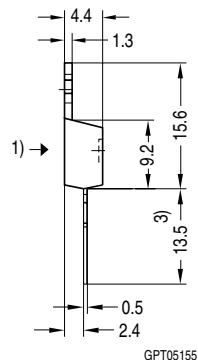


**TO 220 AB**  
 Standard

**Ordering Code**  
 C67078-A5001-A3


1)

→



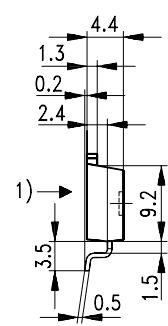
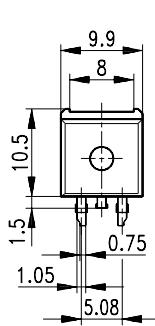
GPT05155

1) punch direction, burr max. 0.04

2) dip tinning

3) max. 14.5 by dip tinning press burr max. 0.05

**TO 220 AB**  
 SMD version E3045

**Ordering Code**  
 C67078-A5001-A9


GPD05164

1) shear and punch direction no burrs this surface

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